



CERTIFICATE

about Product Conformity (QAL1)

Number of Certificate: 0000028732

Certified AMS:

LaserGas II for HCl and H2O

Manufacturer:

NEO Monitors AS Solheimveien 62 A N-1471 Lørenskog

Norway

Test Institute:

TÜV Rheinland Energie und Umwelt GmbH

This is certifying that the AMS has been tested and found to comply with:

EN 15267-1: 2009, EN 15267-2: 2009, EN 15267-3: 2008 and EN 14181: 2004

Certification is awarded in respect of the conditions stated in this certificate (see also the following pages).



- EN 15267-3 tested
- QAL1 certified
- TUV approved
- Annual inspection

Publication in the German Federal Gazette (BAnz.) of 26 January 2011

The certificate is valid until: 25 January 2016

Umweltbundesamt Dessau, 9 February 2011 TÜV Rheinland Energie und Umwelt GmbH Köln, 7 February 2011

i. A. Dr. Hans-Joachim Hummel

ppa. Dr. Peter Wilbring

Pex We

www.umwelt-tuv.de / www.eco-tuv.com

teu@umwelt-tuv.de

Tel. +49 - 221 - 806 - 2275

TÜV Rheinland Energie und Umwelt GmbH

Am Grauen Stein

51105 Köln

Accreditation according to EN ISO/IEC 17025 and certified according to ISO 9001:2008.

qal1.de

info@qal1.de

page 1 of 6





Test report:

936/21212540/A of 6 October 2010

Run of validity until:

25 January 2016

Publication

BAnz. 26 January 2011, No. 14, p. 295, Chapter I No. 3.2

Approved application

The certified AMS is suitable for use at combustion plants according to EC directive 2001-80-EC, at waste incinerations plants according to EC directive 2000-76-EC and other plants requiring official permission. The tested ranges have been chosen with respect to the wide application range of the AMS.

The suitability of the AMS for this application was assessed on the basis of a laboratory test and a three months test on municipal waste incineration plant.

The AMS is approved for the temperature range from -20°C to +50°C.

Any potential user should ensure, in consultation with the manufacturer that this AMS is suitable for the installation on which it will be installed.

Basis of the certification

This certification is based on the test report 936/21212540/A of 6 October 2010 of TÜV Rheinland Energie und Umwelt GmbH, on the relevant body (German Umweltbundesamt) assessment and ongoing surveillance of the product and the manufacturing process and the publication in the German Federal Gazette (BAnz. 26 January 2011, No. 14, p. 295, Chapter I No. 3.2: UBA publication from 10 January 2011):

AMS name:

LaserGas II for HCl and H2O

Manufacturer:

NEO Monitors AS, Norway

Application:

For measurements at plants requiring official permission (i.e. 2000-76-EC, waste incineration directive and 2001-80-EC, large combustion plants directive)

Measuring ranges of the suitability test:

Component	Certification range	Additional range	Unit
HCI	0 - 15	0 - 90	mg/m³ *
H ₂ O	0 - 40	0 - 30	Vol% *

^{*} at 1 m measurement path

Software version:

GM6.d5





Remarks:

- Wet test gases have to be used for checks of HCL and H₂O.
- 2. The maintenance interval is 4 weeks.
- 3. The AMS has been tested at an active measurement path of 0.513 m on the laboratory.
- 4. The AMS has been tested at an active measurement path of 1 m on the field.

Test report:

TÜV Rheinland Energie und Umwelt GmbH, Köln Report-No.: 936/21212540/A from 6 October 2010

Certified product

This certificate applies to automated measurement systems confirming to the following description: The LaserGas II is an optical instrument based on transmitting infrared laser light from a transmitter unit of one side of the stack to a receiver unit on the diametrically opposite side of the stack. The measuring technique is based on measuring the absorption of light by the gas molecules present in the stack.

The measuring principle is called infrared single-line absorption spectroscopy and is based on the fact that most gases absorb light at certain wavelengths. The absorption is a direct function of the gas concentration in the stack.

The tested system comprises the following parts:

- Transmitter with purge gas device and evaluation system
- Receiver unit with purge gas device and internal reference cuvette
- Data cable of 5 m length for connecting the sender and receiver unit
- Voltage supply
- Heated measuring path (active measuring path length: 0.513 m)
- System software, Version GM6.1d5

General notes

This certificate is based upon the equipment tested. The manufacturer is responsible for ensuring that on-going production complies with the requirements of the EN 15267. The manufacturer is required to maintain an approved quality management system controlling the manufacture of the certified product. Both the product and the quality management systems shall be subject to regular surveillance.

If a certified product is found no longer to comply with the applicable European Standard, TÜV Rheinland Energie und Umwelt GmbH should be notified at the address shown on page 1.

The certification mark with the product specific ID-Number that can be applied to the product or used in publicity material for the certified product is presented on page 1 of this certificate.

This document as well as the certification mark remains the property of TÜV Rheinland Energie und Umwelt GmbH. With revocation of the publication the certificate looses its validity. After the expiration of the validity of the certificate and on requests of the TÜV Rheinland Energie und Umwelt GmbH this document shall be returned and the certificate mark must not be employed anymore.

The relevant version of this certificate and the validity is also seen at the Internet Address: qal1.de.





Certification of LaserGas II for HCl and H₂O is based on the documents listed below and the regular, continuous monitoring of the Quality Management System of the manufacturer:

Initial certification according to EN 15267:

Certificate No. 0000028732:

9 February 2011

Validity of the certificate until:

25 January 2016

Test report: 936/21212540/A of 6 October 2010, TÜV Rheinland Energie und Umwelt GmbH, Köln,

Publication: BAnz. 26 January 2011, No. 14, p. 295, Chapter I No. 3.2:

Announcement by UBA from 10 January 2011.





Calculation of overall uncertainty for QAL1 in EN 14181 and EN 15267-3

	Manufacturer data		NEO -	nito	
	Manufacturer Name of measuring system		Laser	nonitors	
	Serial Number		4266 /		
					21/
	Measuring Principle		Sirigle	line spectroscop	Э
	TÜV Data				
	Approval Report	936/21212540/A / 201			10-10-06
	Editor		Schnei	ider	
	Date		2010-1	0-06	
	Measurement Component		HCI		
	Certificated range		15	mg/m³	
	Continuated rungs		10	mg/m	
	Evaluation of the cross sensitivity (CS)				
	Sum of positive CS at zero point		0.00	mg/m³	
	Sum of negative CS at zero point		0.00	mg/m³	
	Sum of postive CS at reference point		0.00	mg/m³	
	Sum of negative CS at reference point		0.00	mg/m³	
	Maximum sum of cross sensitivities			mg/m³	
	Uncertainty of cross sensitivity		0.00	mg/m³	
	Calculation of the combined standard uncertainty				
	Test Value		u		U ²
	Standard deviation from paired measurements under field conditions *	u_D	0.242	mg/m³	0.059 (mg/m³)²
	Lack of fit	u_{lof}	0.081	mg/m³	0.007 (mg/m³)²
	Zero drift from field test	$\mathbf{u}_{d,z}$	0.061	mg/m³	0.004 (mg/m³)²
	Span drift from field test	$u_{d,s}$		mg/m³	0.013 (mg/m³)²
	Influence of ambient temperature at span	u _t		mg/m³	0.010 (mg/m³)²
	Influence of supply voltage	u_{v}		mg/m³	0.001 (mg/m³)²
	Cross sensitivity (interference)	Ui		mg/m³	0.000 (mg/m³)²
	Influence of sample pressure	u_p		mg/m³	0.013 (mg/m³)²
	Uncertainty of reference material at 70% of certification range	u _{rm}		mg/m³	0.015 (mg/m³)²
	Excursion of measurement beam	u_{mb}	-0.146	mg/m³	0.021 (mg/m³)²
	* The bigger value of: "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions"				
	Combined standard uncertainty (u _C)	$u_c = 1$	$\sqrt{\sum (u_{ma})}$) ²	0.38 mg/m³
	Total expanded uncertainty		* k = u _c		0.74 mg/m³
	Relative total expanded uncertainty	U in %	6 of the E	ELV 10 mg/m³	7.4
	Requirement of 2000/76/EC and 2001/80/EC			ELV 10 mg/m³	40,0
Requirement of EN 15267-3 U in % of the				_	30,0





Calculation of overall uncertainty according to EN 14181 and EN 15267-3

	Measuring system Manufacturer Name of measuring system Serial number of the candidates Measuring principle Test report Test laboratory Date of report	NEO Monitors LaserGas II 4266 / 4267 Single-line spectroscopy 936/21212540/A TÜV Rheinland 2010-10-06					
Evaluation of the cross sensitivity (CS) (system with largest CS) Sum of positive CS at zero point 0.00 Vol% Sum of positive CS at zero point 0.00 Vol% Sum of positive CS at zero point 0.00 Vol% Sum of positive CS at zero point 0.00 Vol% Sum of positive CS at reference point 0.00 Vol% Sum of positive CS at reference point 0.00 Vol% Sum of positive CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% 0.000 Vol% Sum of negative CS at reference point 0.00 Vol% 0.000 Vol% 0.003 (Vol%)² Sum of the combined standard uncertainty 0.00 Sum of the combined standard uncertainty 0.00 Sum of the reference of supply voltage 0.00 Sum of the sum of the positive of supply voltage 0.00 Sum of the sum of the positive of supply voltage 0.00 Sum of the sum of the positive of sumple pressure 0.00 Sum of the sum of the positive of sumple pressure 0.00 Sum of the sum o	Measured component	H ₂ O					
(system with largest CS) Sum of positive CS at zero point Sum of negative CS at zero point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Sum of negative CS at reference point 0.00 Vol% Maximum sum of cross sensitivities 0.00 Vol% Uncertainty of cross sensitivities 0.00 Vol% Calculation of the combined standard uncertainty Tested parameter Standard deviation from paired measurements under field conditions * u_0 0.622 Vol% Lack of fit u_0 0.622 Vol% u_0 0.038 (Vol%)² Lack of fit u_0 0.058 Vol% u_0 0.034 (Vol%)² Zero drift from field test u_0 0.155 Vol% u_0 0.034 (Vol%)² Span drift from field test u_0 0.155 Vol% u_0 0.030 (Vol%)² Influence of ambient temperature at span u_1 0.115 Vol% u_1 0.115 Vol% u_1 0.000 Vol% Cross sensitivity (interference) u_1 0.000 Vol% u_0 0.000 (Vol%)² Uncertainty of reference material at 70% of certification range u_0 0.077 Vol% u_0 0.006 (Vol%)² Excursion of measurement beam u_0 0.072 (u_0 0.082 Vol% u_0 0.033 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%)² Excursion of measurement beam u_0 0.077 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.077 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.075 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.076 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.076 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.076 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.076 (Vol%) 0.006 (Vol%)² Excursion of measurement beam u_0 0.077 (Vol% 0.006 (Vol%)² Excursion of measurement beam $u_$	Certification range	0 - 40	Vol%				
Tested parameter u u² u² Standard deviation from paired measurements under field conditions * u_{D} 0.622 Vol% 0.387 (Vol%)² Lack of fit u_{lof} -0.058 Vol% 0.003 (Vol%)² Zero drift from field test $u_{d,z}$ 0.185 Vol% 0.034 (Vol%)² Span drift from field test $u_{d,s}$ -0.323 Vol% 0.104 (Vol%)² Influence of ambient temperature at span u_t 0.115 Vol% 0.104 (Vol%)² Influence of supply voltage u_v 0.189 Vol% 0.036 (Vol%)² Influence of sample pressure u_i 0.000 Vol% 0.006 (Vol%)² Uncertainty of reference material at 70% of certification range u_m 0.077 Vol% 0.006 (Vol%)² Excursion of measurement beam u_m 0.323 Vol% 0.035 (Vol%)² * The larger value is used: "Repeatability standard deviation at span" or u_m u_m u_m u_m u_m u_m	(system with largest CS) Sum of positive CS at zero point Sum of negative CS at zero point Sum of postive CS at reference point Sum of negative CS at reference point Maximum sum of cross sensitivities	0.00 0.00 0.00 0.00	Vol% Vol% Vol% Vol%				
Tested parameter u u² u² Standard deviation from paired measurements under field conditions * u_{D} 0.622 Vol% 0.387 (Vol%)² Lack of fit u_{lof} -0.058 Vol% 0.003 (Vol%)² Zero drift from field test $u_{d,z}$ 0.185 Vol% 0.034 (Vol%)² Span drift from field test $u_{d,s}$ -0.323 Vol% 0.104 (Vol%)² Influence of ambient temperature at span u_t 0.115 Vol% 0.104 (Vol%)² Influence of supply voltage u_v 0.189 Vol% 0.036 (Vol%)² Influence of sample pressure u_i 0.000 Vol% 0.006 (Vol%)² Uncertainty of reference material at 70% of certification range u_m 0.077 Vol% 0.006 (Vol%)² Excursion of measurement beam u_m 0.323 Vol% 0.035 (Vol%)² * The larger value is used: "Repeatability standard deviation at span" or u_m u_m u_m u_m u_m u_m	Calculation of the combined standard uncertainty						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		u		U ²			
Zero drift from field test $u_{d,z} = 0.185 \text{ Vol}\% = 0.034 \text{ (Vol}\%)^2$ Span drift from field test $u_{d,s} = -0.323 \text{ Vol}\% = 0.104 \text{ (Vol}\%)^2$ Influence of ambient temperature at span $u_t = 0.115 \text{ Vol}\% = 0.013 \text{ (Vol}\%)^2$ Influence of supply voltage $u_v = 0.189 \text{ Vol}\% = 0.036 \text{ (Vol}\%)^2$ Cross sensitivity (interference) $u_i = 0.000 \text{ Vol}\% = 0.000 \text{ (Vol}\%)^2$ Influence of sample pressure $u_p = 0.077 \text{ Vol}\% = 0.006 \text{ (Vol}\%)^2$ Uncertainty of reference material at 70% of certification range $u_{rm} = 0.323 \text{ Vol}\% = 0.006 \text{ (Vol}\%)^2$ Excursion of measurement beam $u_{mb} = -0.182 \text{ Vol}\% = 0.033 \text{ (Vol}\%)^2$ * The larger value is used: "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions" Combined standard uncertainty (u_c) $u_c = \sqrt{\sum (u_{max,j})^2} = 0.85 \text{ Vol}\%$ Total expanded uncertainty $u_c = 0.000 \text{ (Vol}\%)^2$ Total expanded uncertainty $u_c = 0.000 \text{ (Vol}\%)^2$ U in % of the range 40 Vol% A22 Requirement of 2000/76/EC and 2001/80/EC U in % of the range 40 Vol% 10,0	Standard deviation from paired measurements under field conditions *	u _D 0.622	Vol%	0.387	(Vol%) ²		
Span drift from field test $u_{d,s} = -0.323 \text{Vol\%} \qquad 0.104 (\text{Vol\%})^2$ Influence of ambient temperature at span $u_t = 0.115 \text{Vol\%} \qquad 0.003 (\text{Vol\%})^2$ Influence of supply voltage $u_v = 0.189 \text{Vol\%} \qquad 0.036 (\text{Vol\%})^2$ Cross sensitivity (interference) $u_i = 0.000 \text{Vol\%} \qquad 0.000 (\text{Vol\%})^2$ Influence of sample pressure $u_p = 0.077 \text{Vol\%} \qquad 0.006 (\text{Vol\%})^2$ Uncertainty of reference material at 70% of certification range $u_{rm} = 0.323 \text{Vol\%} \qquad 0.105 (\text{Vol\%})^2$ Excursion of measurement beam $u_{mb} = -0.182 \text{Vol\%} \qquad 0.033 (\text{Vol\%})^2$ The larger value is used : "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions" $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Relative total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{Vol\%}$	Lack of fit	u _{lof} -0.058	Vol%	0.003	(Vol%) ²		
Influence of ambient temperature at span $ \begin{array}{c} u_t & 0.115 \text{ Vol\%} \\ 0.013 \text{ (Vol\%)}^2 \\ \text{Influence of supply voltage} \\ \text{Cross sensitivity (interference)} \\ \text{Influence of sample pressure} \\ \text{Uncertainty of reference material at 70\% of certification range} \\ \text{Excursion of measurement beam} \\ \text{W}_{mb} & -0.182 \text{ Vol\%} \\ \text{The larger value is used:} \\ \text{"Repeatability standard deviation at span" or} \\ \text{"Standard deviation from paired measurements under field conditions"} \\ \text{Combined standard uncertainty (u_c)} \\ \text{Total expanded uncertainty} \\ \text{Relative total expanded uncertainty} \\ \text{Requirement of 2000/76/EC and 2001/80/EC}} \\ \text{U in \% of the range 40 Vol\%} \\ \text{U.in \% of the range 40 Vol\%} \\ \text{0.013} \text{ (Vol\%)}^2 \\ \text{0.006} \text{ (Vol\%)}^2 \\ \text{0.007} \text{ (Vol\%)}^2 \\ \text{0.008} \text{ (Vol\%)}^2 \\ \text{0.009} (Vol\%$		$u_{d,z}$ 0.185	Vol%	0.034	(Vol%) ²		
Influence of supply voltage $ \begin{array}{c} u_v & 0.189 \ \ Vol\% \\ Cross \ sensitivity \ (interference) \\ Influence \ of \ sample \ pressure \\ Uncertainty \ of \ reference \ material \ at \ 70\% \ of \ certification \ range \\ Excursion \ of \ measurement \ beam \\ ^* \ The \ larger \ value \ is \ used : \\ "Repeatability \ standard \ deviation \ at \ span" \ or \\ "Standard \ deviation \ from \ paired \ measurements \ under \ field \ conditions" \\ \hline Combined \ standard \ uncertainty \ (u_C) \\ Total \ expanded \ uncertainty \\ \hline Relative \ total \ expanded \ uncertainty \\ \hline Requirement \ of \ 2000/76/EC \ and \ 2001/80/EC \\ \hline \end{array} \ \begin{array}{c} u_v \ 0.189 \ \ Vol\% \\ u_i \ 0.000 \ \ Vol\% \\ u_p \ 0.077 \ \ Vol\% \\ u_m \ 0.323 \ \ Vol\% \\ u_m \ 0.323 \ \ Vol\% \\ 0.033 \ \ (Vol\%)^2 \\ \hline Vol\% \\ \hline 0.85 \ \ Vol\% \\ \hline 0.85 \ \ Vol\% \\ \hline 1.66 \ \ Vol\% \\ \hline 0.85 \ \ Vol\% \\ \hline 0.86 \ \ Vol\% \\ \hline 0.86 \ \ Vol\% \\ \hline 0.87 \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	Span drift from field test	$u_{d,s}$ -0.323	Vol%		,		
Cross sensitivity (interference) $u_{i} = 0.000 \text{Vol\%} \qquad 0.000 (\text{Vol\%})^{2}$ Influence of sample pressure $u_{p} = 0.077 \text{Vol\%} \qquad 0.006 (\text{Vol\%})^{2}$ Uncertainty of reference material at 70% of certification range $u_{rm} = 0.323 \text{Vol\%} \qquad 0.105 (\text{Vol\%})^{2}$ Excursion of measurement beam $u_{rm} = 0.323 \text{Vol\%} \qquad 0.033 (\text{Vol\%})^{2}$ * The larger value is used: "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions" Combined standard uncertainty (u_{c}) $U_{c} = \sqrt{\sum_{c} \left(u_{max,j}\right)^{2}} \qquad 0.85 \text{Vol\%}$ Total expanded uncertainty $U = u_{c} * k = u_{c} * 1.96 \qquad 1.66 \text{Vol\%}$ Relative total expanded uncertainty $U = u_{c} * k = u_{c} * 1.96 \qquad 1.60 \text{Vol\%}$ Requirement of 2000/76/EC and 2001/80/EC		•					
Influence of sample pressure $ \begin{array}{c} u_p & 0.077 \ \text{Vol\%} \\ \text{Uncertainty of reference material at 70\% of certification range} \\ \text{Excursion of measurement beam} \\ \text{* The larger value is used:} \\ \text{"Repeatability standard deviation at span" or} \\ \text{"Standard deviation from paired measurements under field conditions"} \\ \\ \text{Combined standard uncertainty } (u_c) \\ \text{Total expanded uncertainty} \\ \\ \text{Relative total expanded uncertainty} \\ \\ \text{Requirement of 2000/76/EC and 2001/80/EC} \\ \\ \text{U in \% of the range 40 Vol\%} \\ \\ \text{0.006 (Vol\%)^2} \\ \text{0.105 (Vol\%)^2} \\ \text{0.003 (Vol\%)^2} \\ \text{0.006 (Vol\%)^2} \\ \text{0.006 (Vol\%)^2} \\ \text{0.006 (Vol\%)^2} \\ \text{0.007 (Vol\%)^2} \\ \text{0.008 (Vol\%)^2} \\ \text{0.009 (Vol\%)^2}$		· ·					
Uncertainty of reference material at 70% of certification range Excursion of measurement beam							
Excursion of measurement beam $ u_{mb} -0.182 \text{ Vol\%} $ * The larger value is used: "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions" $ u_c = \sqrt{\sum \left(u_{max,j}\right)^2} \qquad 0.85 \text{ Vol\%} $ Total expanded uncertainty $ U = u_c * k = u_c * 1.96 \qquad 1.66 \text{ Vol\%} $ Relative total expanded uncertainty $ U = u_c * k = u_c * 1.96 \qquad 1.66 \text{ Vol\%} $ Requirement of 2000/76/EC and 2001/80/EC $ U = u_c * k = u_c * 1.96 \qquad 1.66 \text{ Vol\%} $,		
* The larger value is used : "Repeatability standard deviation at span" or "Standard deviation from paired measurements under field conditions"	· · · · · · · · · · · · · · · · · · ·	- 1111			()		
Total expanded uncertainty $U = u_c * k = u_c * 1.96 \qquad 1.66 \text{Vol\%}$ Relative total expanded uncertainty $U \text{ in \% of the range 40 Vol\%} \qquad 4.2$ Requirement of 2000/76/EC and 2001/80/EC $U \text{ in \% of the range 40 Vol\%} \qquad 10,0$	* The larger value is used : "Repeatability standard deviation at span" or	u _{mb} -0.182	VOI%	0.033	(VOI%) ²		
Total expanded uncertainty $U = u_c * k = u_c * 1.96 \qquad 1.66 \text{Vol\%}$ Relative total expanded uncertainty $U \text{ in \% of the range 40 Vol\%} \qquad 4.2$ Requirement of 2000/76/EC and 2001/80/EC $U \text{ in \% of the range 40 Vol\%} \qquad 10,0$	Combined standard uncertainty (u.)	$u = \sqrt{\sum u}$	<u>}</u> 2	0.05	\/al_0/		
Relative total expanded uncertainty Requirement of 2000/76/EC and 2001/80/EC U in % of the range 40 Vol% 10,0	• • • •						
Requirement of 2000/76/EC and 2001/80/EC U in % of the range 40 Vol% 10,0	тотат ехранией инсентанну	U − u _c K = U	i _c 1.90	1.00	VUI%		
Requirement of 2000/76/EC and 2001/80/EC U in % of the range 40 Vol% 10,0	Relative total expanded uncertainty	U in % of the	range 40 Vol%		4.2		
					10,0		
	•				•		

^{**} For this component no requirements in the EC-directives 2001/80/EG und 2000/76/EG are given. The chosen value is recommended by the certification body.